

| | Type | L # | Hits | Search Text | DBs | Time Stamp |
|----|------|-----|------|--|---|---------------------|
| 1 | IS&P | L1 | 4761 | (250/306,307,310,311,492.3,492.2,492.22).CCLS. | USPAT; US-PGP UB | 2002/08/22 16:49 |
| 2 | BRS | L2 | 7216 | (silicon adj on adj insulator) or SOI | USPAT; US-PGP UB | 2002/08/22 17:18 |
| 3 | BRS | L3 | 44 | L1 and L2 | USPAT; US-PGP UB | 2002/08/22 16:51 |
| 4 | BRS | L4 | 0 | L3 and (inspection with (electron or SEM)) | USPAT; US-PGP UB | 2002/08/22 17:19 |
| 5 | BRS | L6 | 4 | L5 and (substrate near2 remov\$3) | USPAT; US-PGP UB | 2002/08/22 17:02 |
| 6 | BRS | L5 | 14 | L3 and ((electron adj beam) or SEM) | USPAT; US-PGP UB | 2002/08/22 17:00 |
| 7 | BRS | L7 | 1 | L5 and inspect\$4 | USPAT; US-PGP UB | 2002/08/22 17:00 |
| 8 | BRS | L8 | 227 | L1 and (inspection with (electron or SEM)) | USPAT; US-PGP UB | 2002/08/22 17:01 |
| 9 | BRS | L9 | 8 | L8 and (substrate near2 remov\$3) | USPAT; US-PGP UB | 2002/08/22 17:22 |
| 10 | BRS | L10 | 46 | L8 and (imag\$4 near3 defect) | USPAT; US-PGP UB | 2002/08/22 17:23 |
| 11 | BRS | L11 | 6 | L10 and (bright near4 dark) | USPAT; US-PGP UB | 2002/08/22 17:18 |
| 12 | BFS | L12 | 6238 | (silicon adj on adj insulator) or SOI | EPO; JPO; DEFWEN T; IBM_TD B | 2002/08/22 17:19 |

| | Comments | Error Definition | Errors |
|----|----------|------------------|--------|
| 1 | | | 0 |
| 2 | | | 0 |
| 3 | | | 0 |
| 4 | | | 0 |
| 5 | | | 0 |
| 6 | | | 0 |
| 7 | | | 0 |
| 8 | | | 0 |
| 9 | | | 0 |
| 10 | | | 0 |
| 11 | | | 0 |
| 12 | | | 0 |

| | Type | L # | Hits | Search Text | DBs | Time Stamp |
|----|------|-----|------|--|--|---------------------|
| 13 | BRS | L13 | 1 | L12 and (inspection with (electron or SEM)) | EPO; JPO; DERWEN T; IBM_TD B | 2002/08/22 17:21 |
| 14 | BRS | L14 | 26 | (semiconductor near2 die)and (inspection with (electron or SEM)) | USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B | 2002/08/22 17:22 |
| 15 | BRS | L15 | 0 | L14 and (substrate near2 remov\$3) | USPAT; US-PGP UB | 2002/08/22 17:23 |
| 16 | BRS | L16 | 0 | L14 and (substrate near2 remov\$3) | USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B | 2002/08/22 17:23 |
| 17 | BRS | L18 | 0 | L14 and (imag\$4 near3 defect) | EPO; JPO; DERWEN T; IBM_TD B | 2002/08/22 17:24 |
| 18 | BRS | L17 | 8 | L14 and (imag\$4 near3 defect) | USPAT; US-PGP UB | 2002/08/22 17:24 |

| | Comments | Error Definition | Errors |
|----|----------|------------------|--------|
| 13 | | | 0 |
| 14 | | | 0 |
| 15 | | | 0 |
| 16 | | | 0 |
| 17 | | | 0 |
| 18 | | | 0 |